Start Up Time

Storage Temperature Range







EMS11 H H A -25.000M

RoHS Compliant (Pb-free) 4 Pad 5mm x 7mm SMD 1.8Vdc LVCMOS MEMS Spread Spectrum Oscillator

> Frequency Tolerance/Stability ______ ±50ppm Maximum over -40°C to +85°C

Output Control Function — Tri-State (Disabled Output High Impedance)

10mSec Maximum

-55°C to +125°C

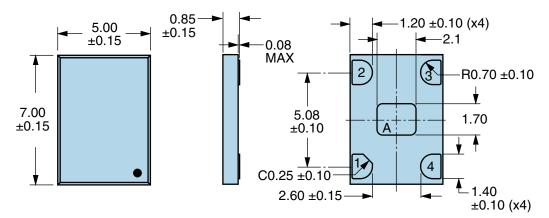
L Nominal Frequency 25.000MHz Spread Spectrum

ELECTRICAL SPECIFICATIONS Nominal Frequency Frequency Tolerance/Stability ±50ppm Maximum over -40°C to +85°C (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, 260°C Reflow, Shock, and Vibration) Aging at 25°C ±1ppm Maximum First Year Supply Voltage 1.8Vdc ±5% **Maximum Supply Voltage** -0.5Vdc to +1.98Vdc 25mA Maximum (Unloaded; Nominal Vdd) **Input Current** Output Voltage Logic High (Voh) 90% of Vdd Minimum (IOH=-8mA) **Output Voltage Logic Low (Vol)** 10% of Vdd Maximum (IOL=+8mA) Rise/Fall Time 2nSec Maximum (Measured from 20% to 80% of waveform) **Duty Cycle** 50 ±5(%) (Measured at 50% of waveform) **Load Drive Capability** 15pF Maximum **Output Logic Type CMOS Output Control Function** Tri-State (Disabled Output High Impedance) 70% of Vdd Minimum or No Connection to Enable Output, 30% of Vdd Maximum to Disable Output Tri-State Input Voltage (Vih and Vil) 20mA Maximum (Disabled Output: High Impedance) (Pad 1=Ground) **Disable Current** Spread Spectrum ±0.25% Center Spread 30kHz Minimum, 32kHz Typical, 35kHz Maximum **Modulation Frequency Period Jitter** 90pSec Maximum (Cycle to Cycle; Spread Spectrum-On; Fo=133.333M, Vdd=1.8Vdc)

| ENVIRONMENTAL & MECHANICAL SPECIFICATIONS | | |
|---|--|--|
| ESD Susceptibility | MIL-STD-883, Method 3015, Class 2, HBM 2000V | |
| Flammability | UL94-V0 | |
| Mechanical Shock | MIL-STD-883, Method 2002, Condition G, 30,000G | |
| Moisture Resistance | MIL-STD-883, Method 1004 | |
| Moisture Sensitivity Level | J-STD-020, MSL 1 | |
| Resistance to Soldering Heat | MIL-STD-202, Method 210, Condition K | |
| Resistance to Solvents | MIL-STD-202, Method 215 | |
| Solderability | MIL-STD-883, Method 2003 (Four I/O Pads on bottom of package only) | |
| Temperature Cycling | MIL-STD-883, Method 1010, Condition B | |
| Thermal Shock | MIL-STD-883, Method 1011, Condition B | |
| Vibration | MIL-STD-883, Method 2007, Condition A, 20G | |



MECHANICAL DIMENSIONS (all dimensions in millimeters)



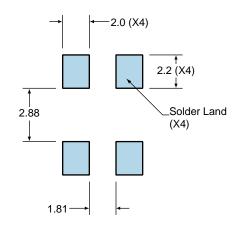
| Note A: Center paddle is connected |
|--|
| internally to oscillator ground (Pad 2). |

| PIN | CONNECTION |
|-----|----------------------------|
| 1 | Tri-State (High Impedance) |
| 2 | Ground |
| 3 | Output |
| 4 | Supply Voltage |

| | MARKING |
|---|------------------------|
| 1 | XXXX or XXXXX |
| | XXXX or XXXXX=Ecliptek |
| | Manufacturing Lot Code |

Suggested Solder Pad Layout

All Dimensions in Millimeters



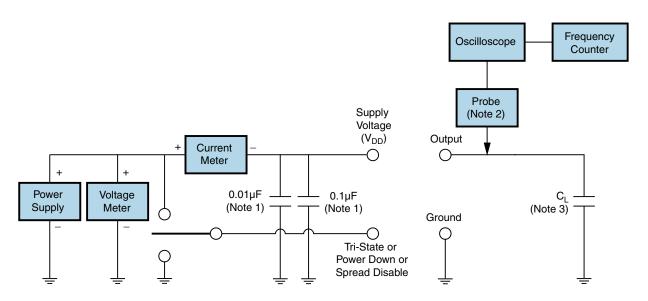
All Tolerances are ±0.1



OUTPUT WAVEFORM & TIMING DIAGRAM



Test Circuit for CMOS Output



Note 1: An external 0.1µF low frequency tantalum bypass capacitor in parallel with a 0.01µF high frequency ceramic bypass capacitor close to the package ground and V_{DD} pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value \dot{C}_L includes sum of all probe and fixture capacitance.



Recommended Solder Reflow Methods



High Temperature Infrared/Convection

| T _s MAX to T _∟ (Ramp-up Rate) | 3°C/second Maximum |
|---|--------------------------------------|
| Preheat | |
| - Temperature Minimum (T _s MIN) | 150°C |
| - Temperature Typical (T _s TYP) | 175°C |
| - Temperature Maximum (T _S MAX) | 200°C |
| - Time (t _s MIN) | 60 - 180 Seconds |
| Ramp-up Rate (T _L to T _P) | 3°C/second Maximum |
| Time Maintained Above: | |
| - Temperature (T∟) | 217°C |
| - Time (t∟) | 60 - 150 Seconds |
| Peak Temperature (T _P) | 260°C Maximum for 10 Seconds Maximum |
| Target Peak Temperature (T _P Target) | 250°C +0/-5°C |
| Time within 5°C of actual peak (tp) | 20 - 40 seconds |
| Ramp-down Rate | 6°C/second Maximum |
| Time 25°C to Peak Temperature (t) | 8 minutes Maximum |
| Moisture Sensitivity Level | Level 1 |
| | |



Recommended Solder Reflow Methods



Low Temperature Infrared/Convection 240°C

| T _S MAX to T _L (Ramp-up Rate) | 5°C/second Maximum |
|---|--|
| Preheat | |
| - Temperature Minimum (T _s MIN) | N/A |
| - Temperature Typical (T _S TYP) | 150°C |
| - Temperature Maximum (T _s MAX) | N/A |
| - Time (t _s MIN) | 60 - 120 Seconds |
| Ramp-up Rate (T _L to T _P) | 5°C/second Maximum |
| Time Maintained Above: | |
| - Temperature (T∟) | 150°C |
| - Time (t∟) | 200 Seconds Maximum |
| Peak Temperature (T _P) | 240°C Maximum |
| Target Peak Temperature (T _P Target) | 240°C Maximum 1 Time / 230°C Maximum 2 Times |
| Time within 5°C of actual peak (tp) | 10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time |
| Ramp-down Rate | 5°C/second Maximum |
| Time 25°C to Peak Temperature (t) | N/A |
| Moisture Sensitivity Level | Level 1 |

Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum.